Search Notes



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Applicant(s)/Patent Under Reexamination

MONTVAY ET AL.

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SEARCHED

Class	Subclass	Date	Examiner
370	60-61, 79	4/27/2007	HSK
709	201-253	4/27/2007	HSK
395	200.11	4/27/2007	HSK
455 ·	550, 560	4/27/2007	

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search	4/27/2007	HSK
George Neurauter (PS) at TC2100 search help	4/27/2007	HSK
Mustafa Meky (Primary/Search Mentor) search help	4/27/2007	HSK
William Vaughn (SPE) search help	4/27/2007	HSK

INTERFERENCE SEARCH

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